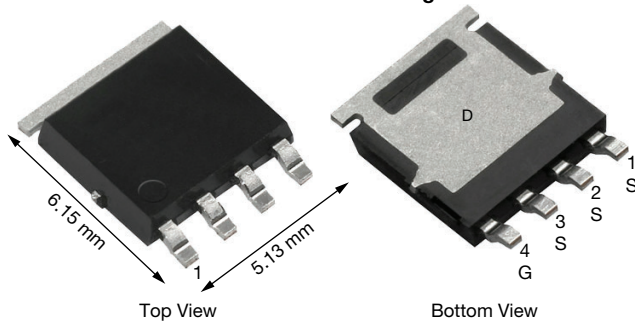
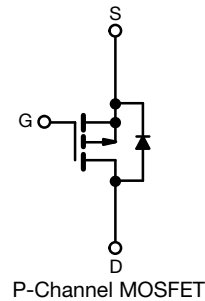


Automotive P-Channel 80 V (D-S) 175 °C MOSFET

PowerPAK® SO-8L Single

FEATURES

- TrenchFET® power MOSFET
- AEC-Q101 qualified
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

AUTOMOTIVE GRADE


RoHS
 COMPLIANT
 HALOGEN
FREE

PRODUCT SUMMARY

V _{DS} (V)	-80
R _{DS(on)} (Ω) at V _{GS} = -10 V	0.0173
R _{DS(on)} (Ω) at V _{GS} = -4.5 V	0.0265
I _D (A)	-46
Configuration	Single
Package	PowerPAK SO-8L

ABSOLUTE MAXIMUM RATINGS (T_C = 25 °C, unless otherwise noted)

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	V _{DS}	-80	V
Gate-source voltage	V _{GS}	± 20	
Continuous drain current	I _D	T _C = 25 °C	-46
		T _C = 125 °C	-26.5
Continuous source current (diode conduction)	I _S	-62	A
Pulsed drain current ^a	I _{DM}	-130	
Single pulse avalanche current	L = 0.1 mH	I _{AS}	-42
Single pulse avalanche energy		E _{AS}	88
Maximum power dissipation ^a	T _C = 25 °C	P _D	68
			T _C = 125 °C
Operating junction and storage temperature range	T _J , T _{stg}	-55 to +175	°C
Soldering recommendations (peak temperature) ^{c, d}		260	

THERMAL RESISTANCE RATINGS

PARAMETER	SYMBOL	LIMIT	UNIT
Junction-to-ambient	R _{thJA}	68	°C/W
Junction-to-case (drain)	R _{thJC}	2.2	

Notes

- Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- When mounted on 1" square PCB (FR4 material)
- See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components



SPECIFICATIONS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0, I_D = -250\text{ }\mu\text{A}$		-80	-	-	V
Gate-source threshold voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$		-1.5	-2.0	-2.5	
Gate-source leakage	I_{GSS}	$V_{DS} = 0\text{ V}, V_{GS} = \pm 20\text{ V}$		-	-	± 100	nA
Zero gate voltage drain current	I_{DSS}	$V_{GS} = 0\text{ V}$	$V_{DS} = -80\text{ V}$	-	-	-10	μA
		$V_{GS} = 0\text{ V}$	$V_{DS} = -80\text{ V}, T_J = 125\text{ }^\circ\text{C}$	-	-	-50	
		$V_{GS} = 0\text{ V}$	$V_{DS} = -80\text{ V}, T_J = 175\text{ }^\circ\text{C}$	-	-	-250	
On-state drain current ^a	$I_{D(on)}$	$V_{GS} = -10\text{ V}$	$V_{DS} \leq -5\text{ V}$	-15	-	-	A
Drain-source on-state resistance ^a	$R_{DS(on)}$	$V_{GS} = -10\text{ V}$	$I_D = -10\text{ A}$	-	0.0143	0.0173	Ω
		$V_{GS} = -10\text{ V}$	$I_D = -10\text{ A}, T_J = 125\text{ }^\circ\text{C}$	-	-	0.0269	
		$V_{GS} = -10\text{ V}$	$I_D = -10\text{ A}, T_J = 175\text{ }^\circ\text{C}$	-	-	0.0322	
		$V_{GS} = -4.5\text{ V}$	$I_D = -6\text{ A}$	-	0.0219	0.0265	
Forward transconductance ^b	g_{fs}	$V_{DS} = -15\text{ V}, I_D = -10\text{ A}$		-	29	-	S
Dynamic ^b							
Input capacitance	C_{iss}	$V_{GS} = 0\text{ V}$	$V_{DS} = -25\text{ V}, f = 1\text{ MHz}$	-	4336	5900	pF
Output capacitance	C_{oss}			-	1495	2100	
Reverse transfer capacitance	C_{rss}			-	53	75	
Total gate charge ^c	Q_g	$V_{GS} = -10\text{ V}$	$V_{DS} = -40\text{ V}, I_D = -10\text{ A}$	-	52	80	nC
Gate-source charge ^c	Q_{gs}			-	13	-	
Gate-drain charge ^c	Q_{gd}			-	5	-	
Gate resistance	R_g	$f = 1\text{ MHz}$		0.5	1.0	1.5	Ω
Turn-on delay time ^c	$t_{d(on)}$	$V_{DD} = -40\text{ V}, R_L = 4\text{ }\Omega,$ $I_D \cong -10\text{ A}, V_{GEN} = -10\text{ V}, R_g = 1\text{ }\Omega$		-	16	25	ns
Rise time ^c	t_r			-	5	10	
Turn-off delay time ^c	$t_{d(off)}$			-	33	55	
Fall time ^c	t_f			-	6	12	
Source-Drain Diode Ratings and Characteristics ^b							
Pulsed current ^a	I_{SM}			-	-	-130	A
Forward voltage	V_{SD}	$I_F = -10\text{ A}, V_{GS} = 0$		-	-0.82	-1.2	V
Body diode reverse recovery time	t_{rr}	$I_F = -10\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$		-	50	100	ns
Body diode reverse recovery charge	Q_{rr}			-	54	110	nC
Reverse recovery fall time	t_a			-	20	-	ns
Reverse recovery rise time	t_b			-	30	-	
Body diode peak reverse recovery current	$I_{RM(REC)}$					-	-1.95

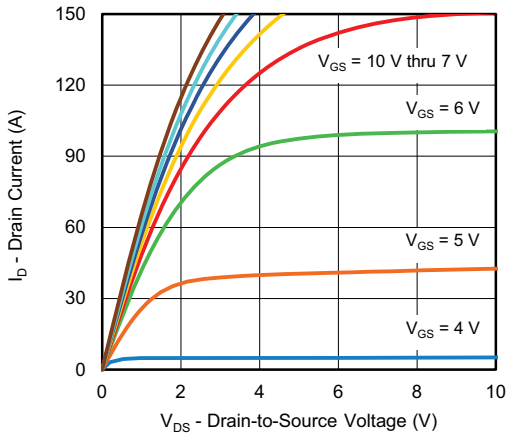
Notes

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$
- b. Guaranteed by design, not subject to production testing
- c. Independent of operating temperature

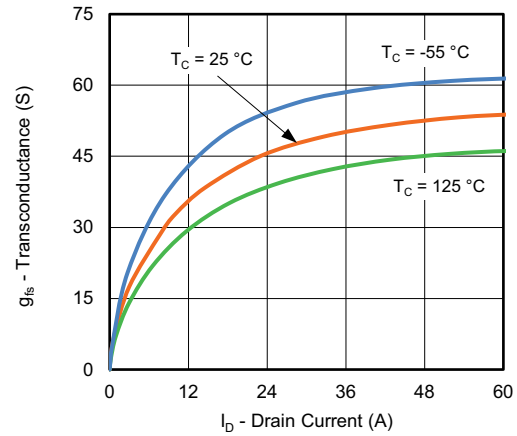
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



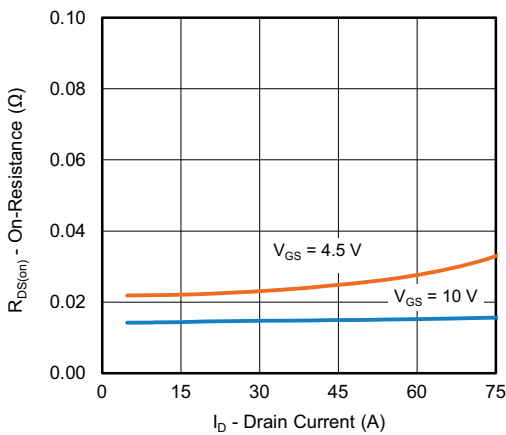
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



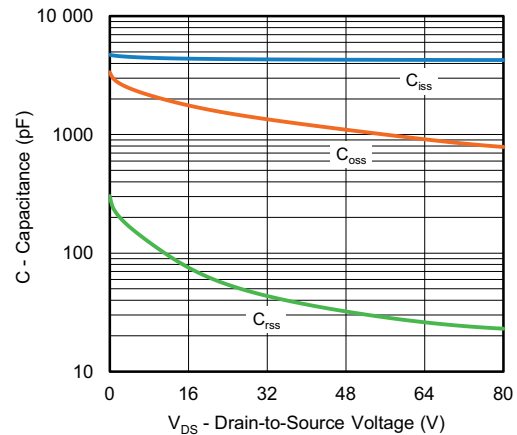
Output Characteristics



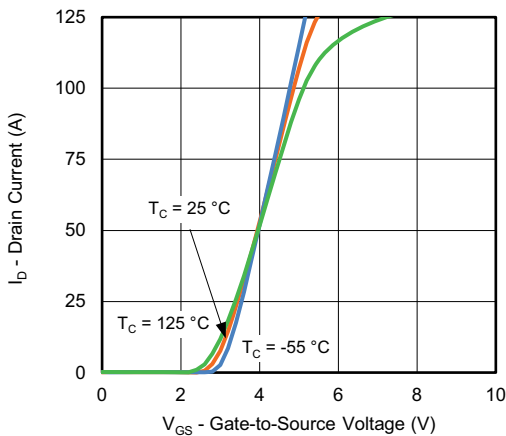
Transconductance



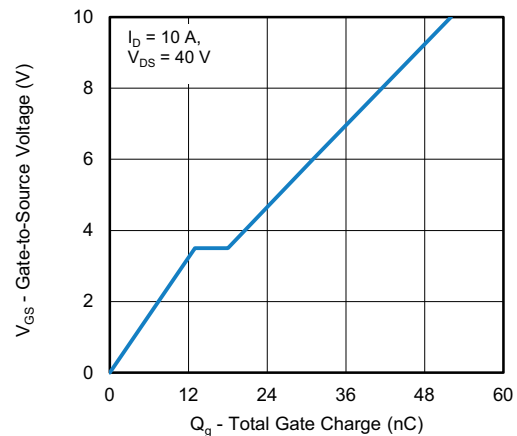
On-Resistance vs. Drain Current



Capacitance



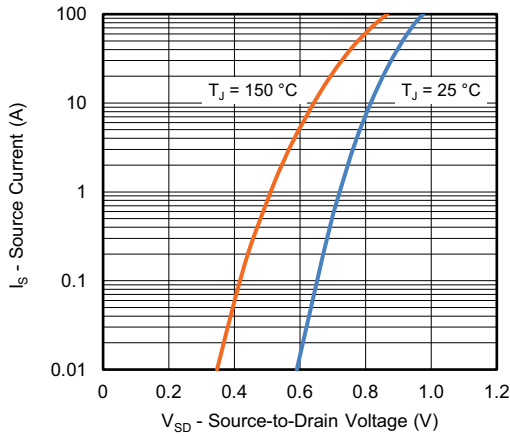
Transfer Characteristics



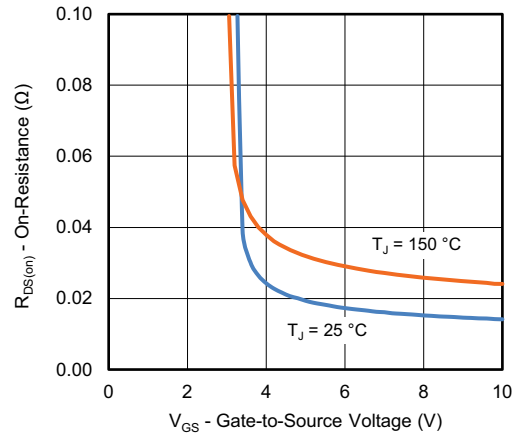
Gate Charge



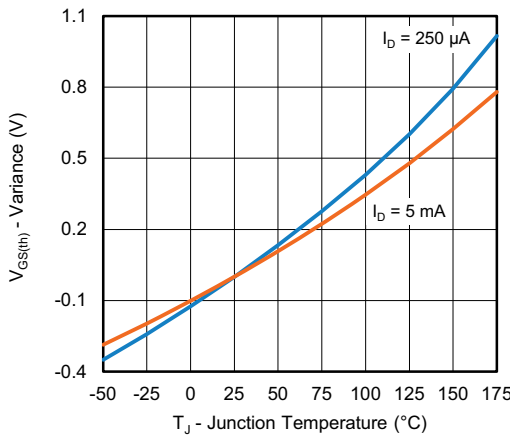
TYPICAL CHARACTERISTICS ($T_A = 25\text{ }^\circ\text{C}$, unless otherwise noted)



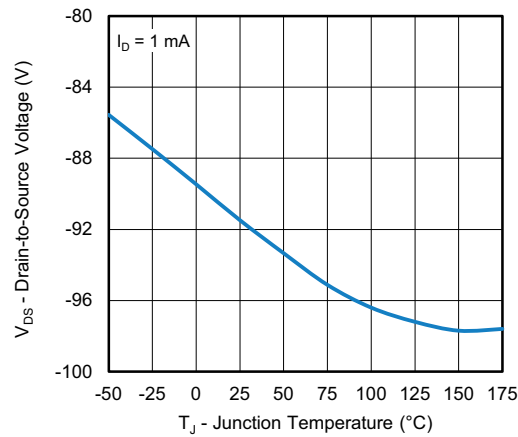
Source Drain Diode Forward Voltage



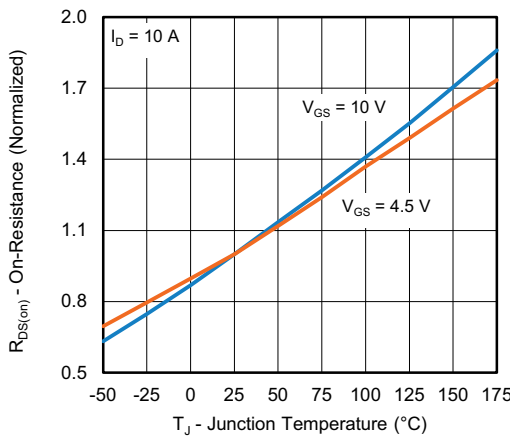
On-Resistance vs. Gate-to-Source Voltage



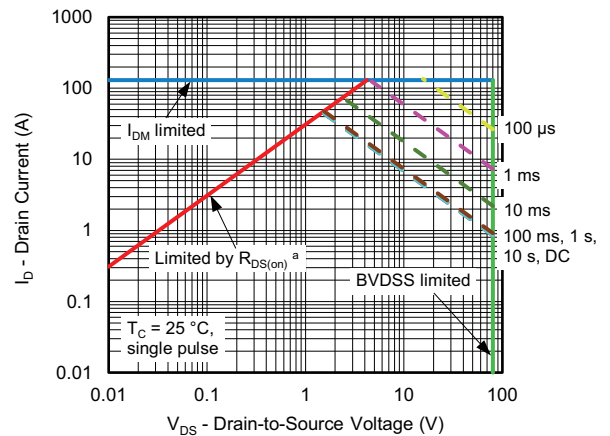
Threshold Voltage



Drain Source Breakdown vs. Junction Temperature



On-Resistance vs. Junction Temperature



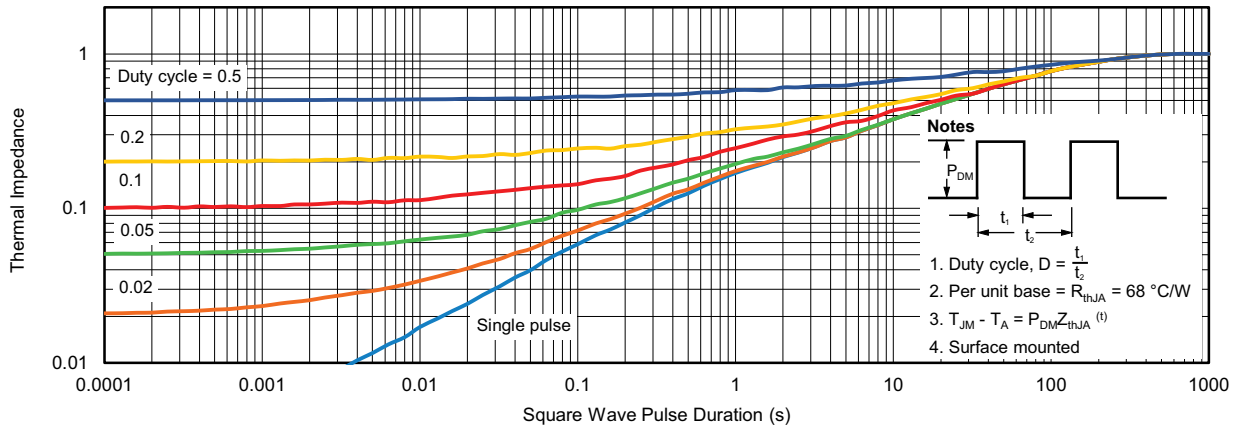
Safe Operating Area

Note

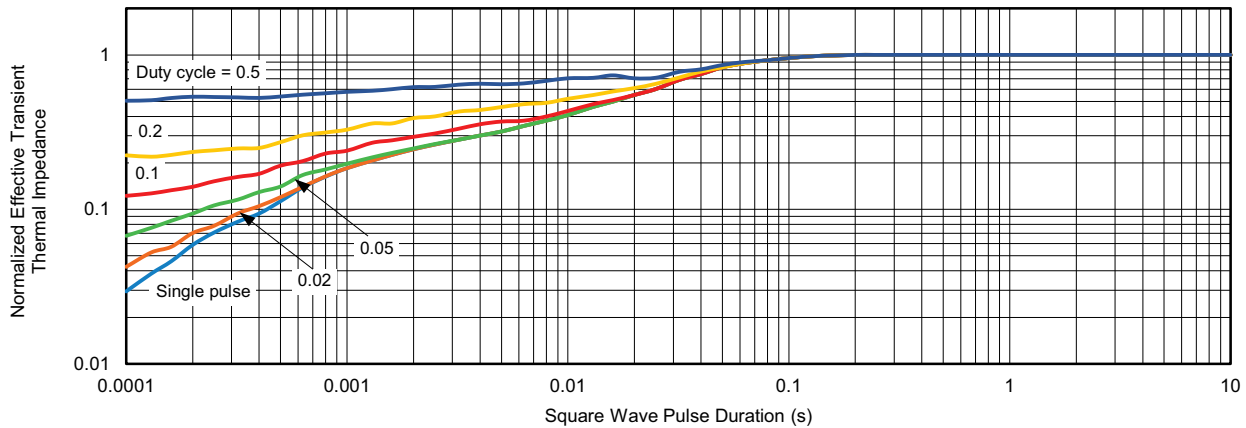
a. $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified



THERMAL RATINGS ($T_C = 25\text{ }^\circ\text{C}$, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient ($25\text{ }^\circ\text{C}$)
 - Normalized Transient Thermal Impedance Junction-to-Case ($25\text{ }^\circ\text{C}$)
 are given for general guidelines only to enable the user to get a “ball park” indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions

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